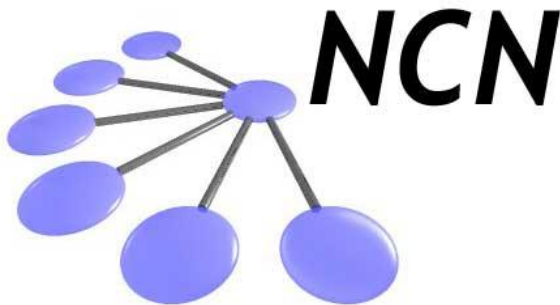


Network for Computational Nanotechnology (NCN)

UC Berkeley, Univ. of Illinois, Norfolk State, Northwestern, Purdue, UTEP

1D Heterostructure Tool on nanoHUB.org



PURDUE
UNIVERSITY

Sebastian Steiger

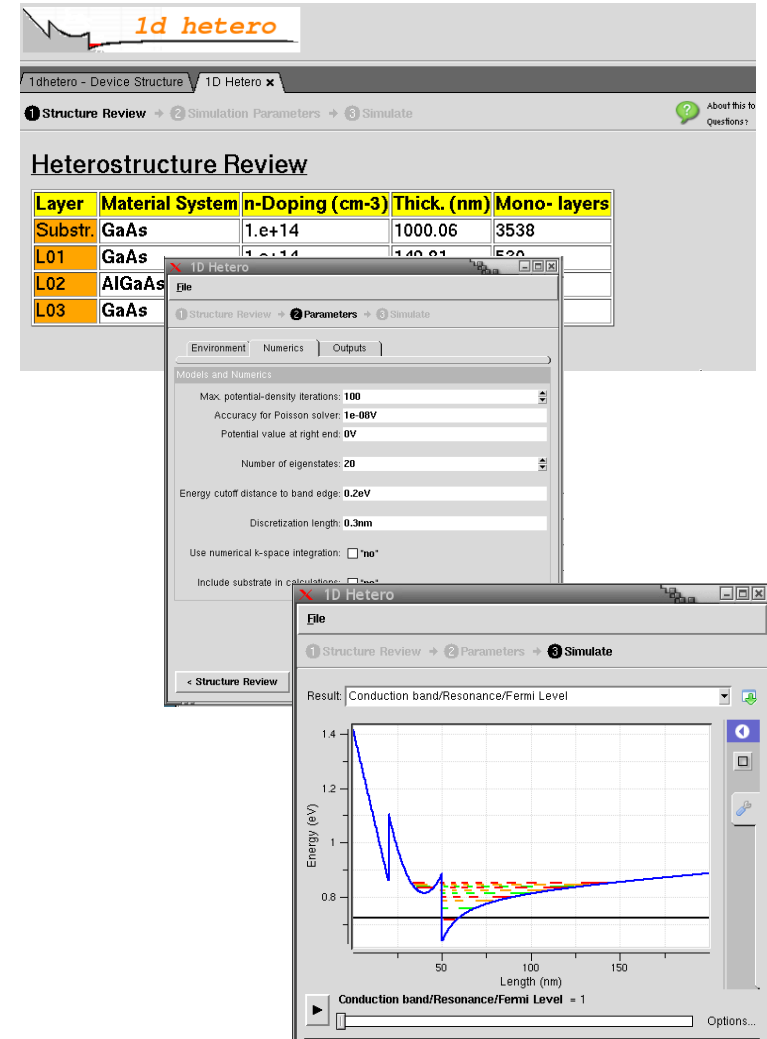
Arun Goud

Jean-Michel Sellier

Gerhard Klimeck

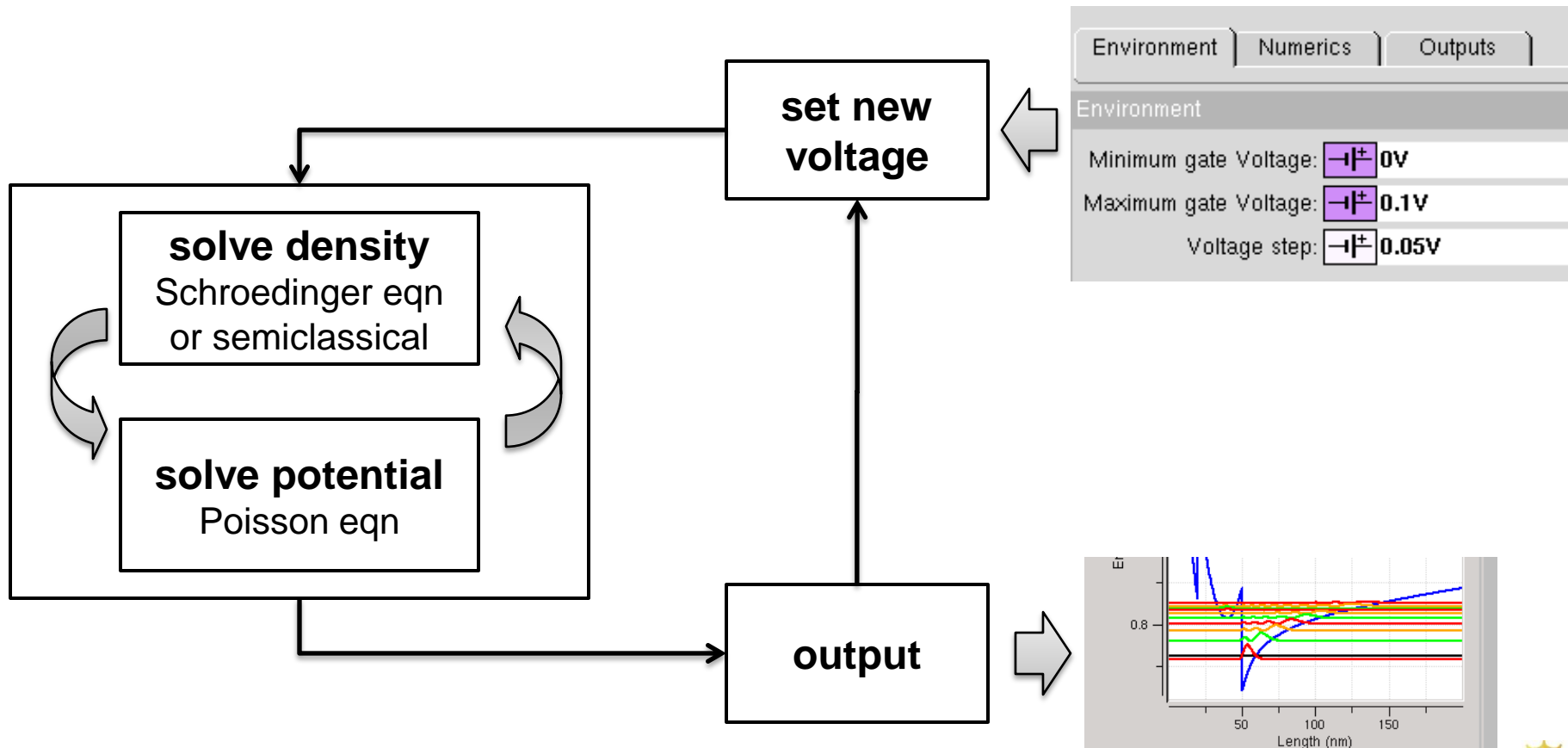
Electrical and Computer Engineering
Purdue University, West Lafayette IN, USA

- Tool overview
- User input
- List of generated **output**
- List of available **materials** and their parameters
- Simulation **examples**
- Facts and parameters
- Validation
- Outlook
- History



Tool Overview

Find **carrier densities**, **electrostatic potential**, **eigenstates** and other quantities in 1D-layered semiconductor heterostructures:



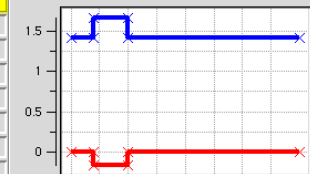
Tool Overview

1d hetero

File Edit

Substrate	Layer	Material System	n-Doping (cm ⁻³)	Thick. (nm)	Mono-layers
GaAs	Substr.	GaAs	1.e+14	1000.06	3538
	L01	GaAs	1.e+14	149.81	530
	L02	AlGaAs	1.e+18	29.96	106
	L03	GaAs	1.e+14	19.79	70
	L04				
	L05				
	L06				
	L07				
	L08				
	L09				
	L10				
	L11				
	L12				
	L13				
	L14				
	L15				
	L16				
	L17				
	L18				
	L19				
	L20				

Energy Band Edge (eV)



1dhetero - Device Structure 1D Hetero x

1 Structure Review → 2 Simulation Parameters → 3 Simulate

Environment Numerics Outputs

Environment

Minimum gate Voltage: 0V

Maximum gate Voltage: 0.1V

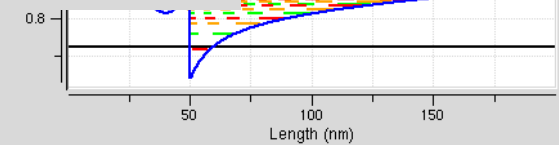
Voltage step: 0.05V

Fermi Level: 0.724eV

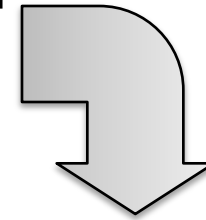
Lattice temperature: 300K

Electron temperature: 300K

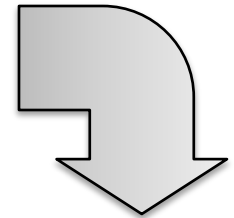
Conduction band/Resonance/Fermi Level = 1



- Structure definition
- Density model
- Temperature



- Applied gate voltage
- Further parameters



- Output graphs

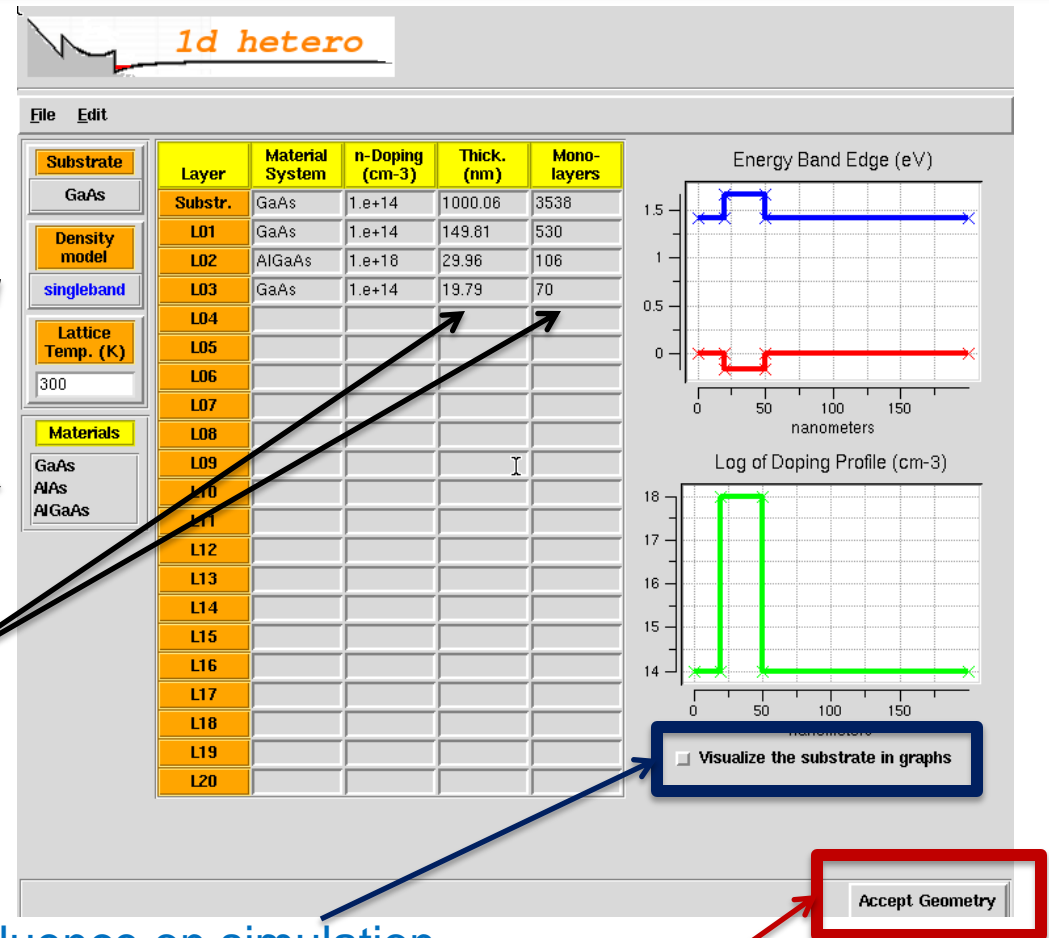
Structure Definition

- Currently only lattice-matched structures are possible (no strain)
- Availability of materials depends on the selected density model
- Enter thickness or #MLs other quantity gets adjusted

has no influence on simulation

click when done

→ afterwards structure cannot be changed anymore



Layer	Material System	n-Doping (cm-3)	Thick. (nm)	Mono-layers
Substr.	GaAs	1.e+14	1000.06	3538
L01	GaAs	1.e+14	149.81	530
L02	AlGaAs	1.e+18	29.96	106
L03	GaAs	1.e+14	19.79	70
L04				
L05				
L06				
L07				
L08				
L09				
L10				
L11				
L12				
L13				
L14				
L15				
L16				
L17				
L18				
L19				
L20				

Physical Models for the Density

Density
model

singleband

$$\rho = e(p - n + N_D)$$

- **Semiclassical density** (no Schroedinger equation needs to be solved):

$$n(x) = N_c F_{0.5} \left(\frac{E_c(x) - e\varphi(x) - E_F}{k_B T} \right), \quad p(x) = N_v F_{0.5} \left(\frac{E_F - E_v(x) + e\varphi(x)}{k_B T} \right)$$

- **Quantum density:** $n(x) = \sum_n \sum_k f_{FD} \left(\frac{E_{nk} - E_F}{k_B T} \right) |\psi_{nk}(x)|^2, \quad p(x) = 0$

» Single-band effective mass Schroedinger equation:

$$\left(-\frac{d}{dx} \frac{\hbar^2}{2m^*(x)} \frac{d}{dx} + E_c(x) - e\varphi(x) \right) \psi_{nk}(x) = E_{nk} \psi_{nk}(x)$$

» Multi-band empirical tight-binding (LCAO) Schroedinger equation:

$$H \psi_{nk}(x) = E_{nk} \psi_{nk}(x), \quad H_{ij} = \langle \phi_i | H | \phi_j \rangle \quad \phi = \text{atomic orbitals}$$

Gate Voltage

1 Structure Review → 2 Simulation Parameters → 3 Simulate

Environment | Numerics | Outputs

Environment

Minimum gate Voltage:

Maximum gate Voltage:

Voltage step:

Fermi Level:

Lattice temperature:

Electron temperature:

Electrostatic potential at the left end will be ramped given by these steps

Globally constant Fermilevel

- Lattice temperature was given in previous screen
→ influences lattice constant
- Electron temperature influences Fermi-Dirac population of eigenstates

Numerical Parameters

Environment | Numerics | Outputs

Models and Numerics

Discretization length: **0.2nm**

Max. potential-density iterations: **100**

Accuracy for Poisson solver: **1e-08V**

Potential value at right end: **0V**

Number of eigenstates: **20**

Energy cutoff distance to band edge: **0.2eV**

Use numerical k-space integration: ☐ "no"

Max. k-vector (0,kmax) and (kmax,0): **0.1**

Num. k-points in every direction: **10**

Include substrate in calculations: ☐ "no"

Real-space discretization for semiclassical and effective-mass simulations

Poisson solver numerical parameters

Number of computed eigenstates for quantum density simulations

Numerical parameter for discrimination between electrons and holes

Options for the treatment of 2D k-space (see next slide)

Allow substrate layer to have density (makes simulation slower)

Default settings are good enough for most users

k-space Treatment

Environment
Numerics
Outputs

Models and Numerics

Use numerical k-space integration: ☐ "no"

Max. k-vector (0,kmax) and (kmax,0): 0.1

Num. k-points in every direction: 10

For Schroedinger simulations two alternatives exist:

1. **Solve only $k=0$** and use

$$\sum_k f_{FD} \left(\frac{E_{nk} - E_F}{k_B T} \right) |\psi_{nk}(x)|^2 \approx \sum_k f_{FD} \left(\left(E_{n0} + \frac{\hbar^2 k^2}{2m_{avg}^*} - E_F \right) / k_B T \right) |\psi_{n0}(x)|^2 = \frac{m_{avg}^* k_B T}{2\pi \hbar^2} \log \left(1 + \frac{E_F - E_{n0}}{k_B T} \right) |\psi_{n0}(x)|^2$$

For effective mass simulations with constant effective mass this method is exact.

2. Do **numerical integration** using solutions of several k -points.

This option submits the job onto a Purdue supercomputer. It is computationally much more expensive and takes longer.

Output Parameters

Environment | Numerics | **Outputs**

Outputs

Resonance Energy Range: **1eV**

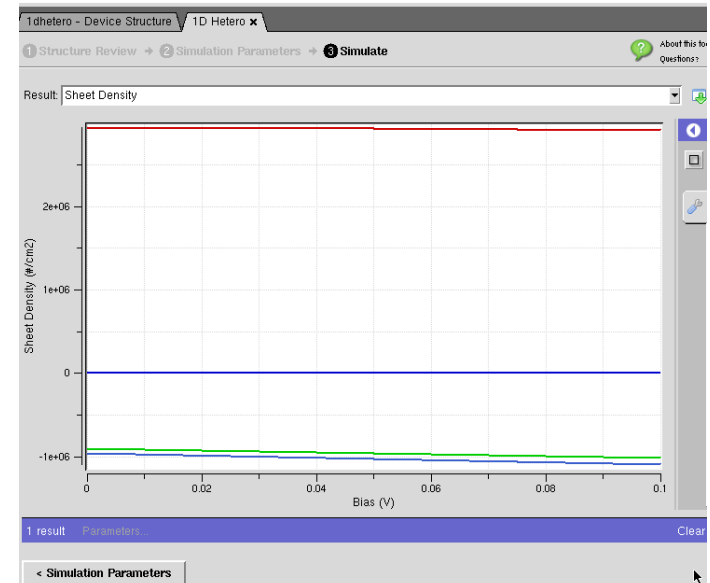
Calculate Sheet Density: ☒ "yes"

Sheet Density: Integration Minimum: **60nm**

Sheet Density: Integration Maximum: **150nm**

If checked, the 3D density will be integrated between the specified boundaries to obtain a 2D density

For quantum density simulations, states in the range $E_F \pm \Delta$ will be displayed.



List of Output Graphs

Graph	Available when?
CB / Resonances / EF	quantum density simulations
CB / EF	semiclassical density simulations
CB / VB / Resonances / EF	quantum density simulations
CB / wave functions	quantum density simulations
Electrostatic potential	always
Doping density	always
Electron density	always
CB / VB w/o electrostatics	always
Sheet density vs. gate voltage	when option is checked
Eigenenergies vs. gate voltage	quantum density simulations

CB = conduction band (including electrostatic potential)

VB = valence band (including electrostatic potential)

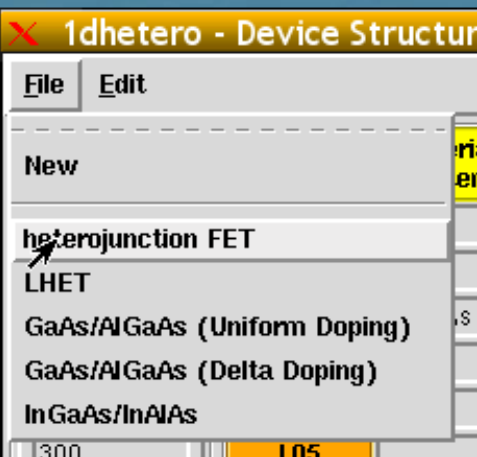
EF = Fermilevel (spatially constant)

Available Material Systems

substrate	material	E_c	E_v	m_e	$sp^3s^*?$	$sp^3d^5s^*?$
GaAs	GaAs	1.422	0.000	0.067	✓	✓
	AlGaAs	1.672	-0.159	0.067		
	AlAs	1.634	-0.530	0.361	✓	✓
GaP	GaP	1.803	-0.470	0.504	✓	✓
	AlP	1.548	-0.940	0.401	✓	✓
GaSb	GaSb	1.497	0.770	0.039	✓	✓
	AlSb	2.006	0.390	0.274	✓	✓
InP	InP	1.213	-0.140	0.080	✓	
	In ₅₃ GaAs	0.948	0.205	0.044	✓	
	In ₅₂ AlAs	1.505	0.015	0.075	✓	
Si	Si	1.125	0.000	1.084	✓	✓
	Ge	1.448	0.545	0.869		✓
	SiO ₂	4.295	-4.705	0.3		✓

- Most effective mass parameters are taken from Vurgaftman 2001.
Effective DOS masses are taken for indirect semiconductors.

Heterostructure Examples (1)



Heterojunction FET:

GaAs, 1e14, 20nm
AlGaAs, 1e18, 30nm
GaAs, 1e14, 150nm
GaAs, 1e14, 800nm

InGaAs/InAlAs:

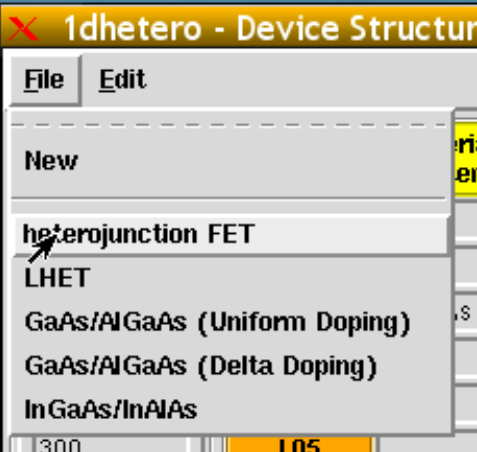
5 nm $\text{In}_{0.53}\text{Ga}_{0.47}\text{As}$ ($2 \times 10^{18} \text{ cm}^{-3}$)	Cap layer
30 nm $\text{In}_{0.53}\text{Al}_{0.47}\text{As}$ ($1 \times 10^{18} \text{ cm}^{-3}$)	Buffer layer
10 nm undoped $\text{In}_{0.53}\text{Al}_{0.47}\text{As}$	Spacer
25 nm undoped $\text{In}_{0.53}\text{Ga}_{0.47}\text{As}$	Quantum well
250 nm undoped $\text{In}_{0.53}\text{Al}_{0.47}\text{As}$	
SI InP (001) substrate	

example courtesy of Prof. D. Vasileska, ASU

LHET:

20nm AlGaAs	
5nm AlGaAs	$\delta\text{-dop } 5 \times 10^{11} \text{ cm}^{-2}$
5nm AlGaAs	$\delta\text{-dop } 5 \times 10^{11} \text{ cm}^{-2}$
5nm AlGaAs	$\delta\text{-dop } 5 \times 10^{11} \text{ cm}^{-2}$
5nm AlGaAs	$\delta\text{-dop } 5 \times 10^{11} \text{ cm}^{-2}$
25nm AlGaAs	$\delta\text{-dop } 5 \times 10^{11} \text{ cm}^{-2}$
40nm AlGaAs	$\delta\text{-dop } 5 \times 10^{11} \text{ cm}^{-2}$
50nm GaAs	
200nm GaAs (001)	

Heterostructure Examples (2)

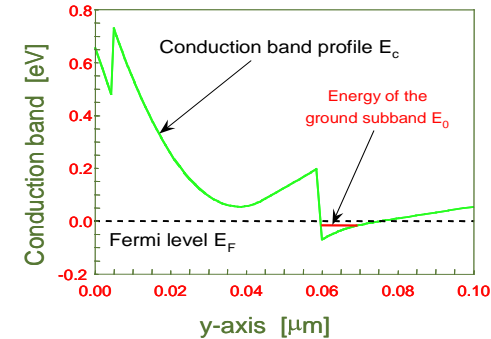


- GaAs/AlGaAs w/ uniform doping

MBE Grown Heterostructure with uniformly doped layer

5 nm GaAs (cap layer)
40 nm Si-doped $\text{Al}_x\text{Ga}_{1-x}\text{As}$ (barrier layer)
15 nm $\text{Al}_x\text{Ga}_{1-x}\text{As}$ (spacer layer)
0.1 μm ud-GaAs substrate
Semi-insulating GaAs substrate

Conduction band profile along the growth direction

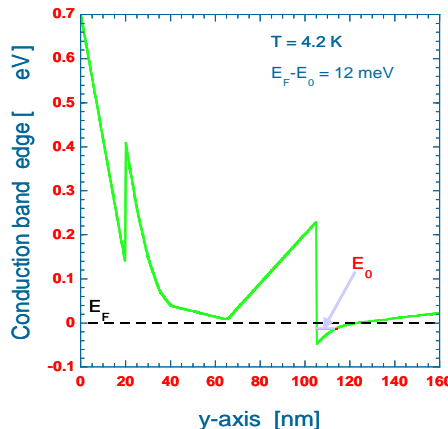


Calculated channel electron density for the ungated structure is $N_s = 4.26 \times 10^{11} \text{ cm}^{-2}$. The experimental measurements revealed $N_s = 4.1 \times 10^{11} \text{ cm}^{-2}$, in close agreement with our simulation results.

MBE Grown Heterostructure with δ -doped layers

200 Å GaAs undoped
N_{d1} 4x50 Å AlGaAs undoped
N_{d2} 250 Å AlGaAs undoped
400 Å AlGaAs undoped
1 μm GaAs undoped
SI GaAs

$N_{d1} = 1 \times 10^{12} \text{ cm}^{-2}$ Si
 $N_{d2} = 3 \times 10^{12} \text{ cm}^{-2}$ Si



- GaAs/AlGaAs w/ δ -doping

examples courtesy of Prof. D. Vasileska, ASU

Facts and Parameters

- For multi-band simulations the discretization is given by the atomic lattice.
- The Fermilevel is spatially constant and fixed during the simulation.
- Zero density in the “substrate” material is assumed except when the designated option is checked.
- In the case of varying effective masses and analytical k-space, the assumed effective mass for the lateral dispersion is

$$m_{avg}^* = \int m^*(x) |\psi(x)|^2 dx.$$

- For numerical k-space integration, by default a sample of 100 k-points is taken over the square $[0, 2\pi/4a] \times [0, 2\pi/4a]$ (and multiplied by 4).
- The multiband tight-binding parameter sets are *not* temperature-dependent so changing the temperature will have no effect on the simulation.
- For multiband simulations, a quantum state E_{nk} is assumed to be an electron according to the (spatially dependent) criterion

$$E_{nk} > E_c - e\varphi(x) - \Delta.$$

The parameter Δ is 0.2 eV by default and adjustable in the Numerics section of the GUI.

- Bulk $E(k)$ band structure diagrams of most materials and models were validated against literature:

Model	Source
Ec, Ev, me	Vurgaftman et al., JAP 89, 5815 (2001)
sp3s*	Klimeck et al., Superlatt. 27, 519 (2000) Klimeck et al., Superlatt. 27, 77 (2000) NEMO-1D
sp3d5s*	Jancu et al., PRB 57, 6493 (1998) Boykin et al., PRB 69, 115201 (2004)

- The Poisson solver was validated against analytical results.
- The Schroedinger-Poisson iteration result was compared to previous versions of the tool that had an independent codebase.

- Ternary materials with flexible mole fractions
- Holes
- Strain
- Varying crystal orientations (multiband only)
- Nitrides



History of the Tool

1d_hetero is an ongoing outreach effort by the Klimeck group @Purdue:

- First *Matlab* prototype by [Samarth Agarwal](#) (<1.0.3).
- *New-NEMO* 3D simulation engine by [Sunhee Lee](#) (1.0.3-2.x).
- *NEMO* 5 simulation engine by [Sebastian Steiger](#), [Michael Povolotskyi](#), [Tillmann Kubis](#) and [Hong-Hyun Park](#) (>3.0). Material database by [Ben Hailey](#) (>3.0).
- Initial *Tcl/Tk* and *Rappture* GUIs by [Jean-Michel Sellier](#) (1.0.3-2.x) and [Xufeng Wang](#) (<1.0.3).
- Current (>3.0) GUI and maintenance by [Arun Goud](#) under supervision of S. Steiger.
- General supervision: [Gerhard Klimeck](#). Counseling: [Dragica Vasileska](#).

Last update of this document: Jan 2011